



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In application of: Testoni

Attorney Docket No.: KLA1P107/P1088

Application No.: 10/796,577

Examiner: Anthony G. Quash

Filed: March 8, 2004

Group: 2881

Title: RAPID DEFECT COMPOSITION
MAPPING USING MULTIPLE X-RAY
EMISSION PERSPECTIVE DETECTION
SCHEME

CERTIFICATE OF MAILING

I hereby certify that this correspondence is being deposited with the U.S. Postal Service with sufficient postage as first-class mail on February 17, 2006 in an envelope addressed to the Commissioner for Patents, P.O. Box 1450 Alexandria, VA 22313-1450.

Signed: _____

Mia Mitchell-Haynes

**SEPARATE LETTER TO THE OFFICIAL DRAFTSMAN
REQUESTING ENTERING OF FORMAL DRAWINGS
(MPEP 608.02(p))**

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

In response to the objections made due to informalities in the original drawings (or to corrections approved by the Examiner), enclosed are ten (10) sheets of "Replacement" drawings for the above-identified patent application. If the Draftsman has any question concerning these drawings, he or she is respectfully requested to contact the undersigned.

Respectfully submitted,
BEYER WEAVER & THOMAS, LLP

Mary R. Olynick
Registration No. 42,963

P.O. Box 70250
Oakland, CA 94612-0250
(510) 663-1100